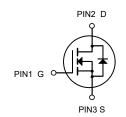


## **Description**

The FDPF16N50 can be used in various power swithching circuit for system miniaturization and higher efficiency. The package form is TO-220/TO-220F, which accords with the RoHS standard.

# G D S

### **TO-220F**



#### N-Channel MOSFET

#### **General Features**

 $V_{DS} = 500V, I_{D} = 20A$ 

 $R_{DS(ON)} < 0.3 \Omega@V_{GS}=10V$ 

# **Application**

• Power switch circuit of adaptor and charger.

# **Package Marking and Ordering Information**

Product ID	Pack	Brand	Units Tube
FDPF16N50	TO-220F	HXY MOSFET	50

# Absolute Maximum Ratings@T=25°C(unless otherwise specified)

Symbol	Parameter	Limit	Unit		
V <sub>DSS</sub>	Drain-to-Source Voltage <sup>[1]</sup>	500			
V <sub>GSS</sub>	Gate-to-Source Voltage	±30			
I <sub>D</sub>	Continuous Drain Current	20			
I <sub>D @ Tc =100°C</sub>	Continuous Drain Current @ Tc=100°C Figure 3		A		
I <sub>DM</sub>	Pulsed Drain Current at V <sub>GS</sub> =10V <sup>[2]</sup>	Figure 6			
E <sub>AS</sub>	Single Pulse Avalanche Energy	1500	mJ		
dv/dt	Peak Diode Recovery dv/dt <sup>[3]</sup>	5.0	V/ns		
P <sub>D</sub>	Power Dissipation	165	W		
T <sub>L</sub> T <sub>PAK</sub>	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds		°C		
T <sub>J</sub> & T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to 150			
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	2.27	0000		
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	100	°C/W		

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.



# Electrical Characteristics (TJ = 25°C unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	500			V	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA
	Drain-to-Source Leakage Current			1	uA -	$V_{DS}$ =500V, $V_{GS}$ =0V
I <sub>DSS</sub>				100		$V_{DS}$ =400V, $V_{GS}$ =0V, $T_J$ =125°C
I <sub>GSS</sub>	Gate-to-Source Leakage Current			+100	nA -	$V_{GS}$ =+30V, $V_{DS}$ =0V
				-100		$V_{GS}$ =-30V, $V_{DS}$ =0V
R <sub>DS(ON)</sub>	Static Drain-to-Source On-Resistance <sup>[4]</sup>		0.26	0.3	Ω	V <sub>GS</sub> =10V, I <sub>D</sub> =10A
V <sub>GS(TH)</sub>	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}=V_{GS}$ , $I_D=250uA$
gfs	Forward Transconductance <sup>[4]</sup>		17		S	VDS=15V,ID=10A
C <sub>iss</sub>	Input Capacitance		2864			$V_{GS}$ =0V, $V_{DS}$ =25V, $f$ =1.0MH $_{Z}$
C <sub>rss</sub>	Reverse Transfer Capacitance		25		pF	
C <sub>oss</sub>	Output Capacitance		286			
Qg	Total Gate Charge		63			$V_{DD}$ =250V, $I_{D}$ =20A, $V_{GS}$ =0 to 10V
Q <sub>gs</sub>	Gate-to-Source Charge		14		nC	
$Q_{gd}$	Gate-to-Drain (Miller) Charge		24			
td(ON)	Turn-on Delay Time		33			$V_{DD}$ =250V, $I_{D}$ =20A, $V_{GS}$ = 10V $R_{G}$ =25 $\Omega$
trise	Rise Time		75			
td(OFF)	Turn-Off Delay Time		181		nS	
<b>t</b> fall	Fall Time		83			
I <sub>SD</sub>	Continuous Source Current <sup>[4]</sup>			20	^	Integral PN-diode in MOSFET
I <sub>SM</sub>	Pulsed Source Current <sup>[4]</sup>			80	Α	
V <sub>SD</sub>	Diode Forward Voltage			1.5	V	I <sub>S</sub> =20A, V <sub>GS</sub> =0V
trr	Reverse recovery time		392		V	V <sub>GS</sub> =0V ,I <sub>F</sub> =20A,
Qrr	Reverse recovery charge		3.3		uC	dir/dt=100A/μs

#### Note:

<sup>[1]</sup>  $T_J$ =+25°C to +150°C

<sup>[2]</sup> Repetitive rating; pulse width limited by maximum junction temperature.

<sup>[3]</sup> ISD= 20A di/dt < 100 A/μs, VDD < BVDSS, TJ=+150°C. [4] Pulse width≤380μs; duty cycle≤2%.

## **Typical Characteristics**

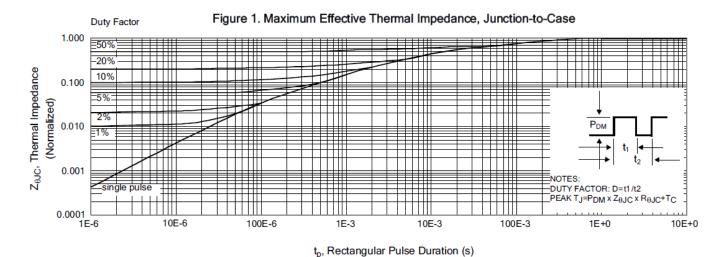


Figure 2. Maximum Power Dissipation vs Case Temperature

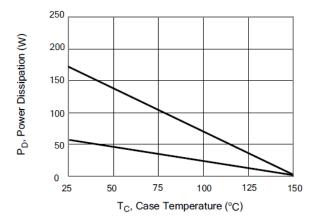


Figure 4. Typical Output Characteristics

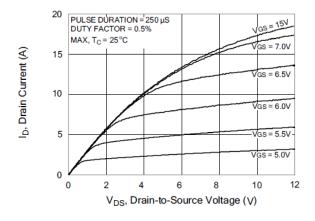


Figure 3. Maximum Continuous Drain Current vs Case Temperature

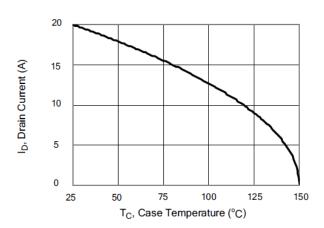
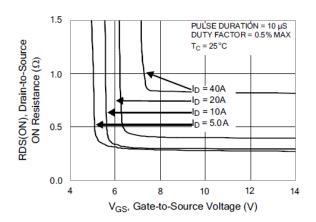


Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current



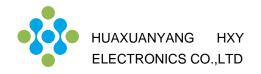


Figure 6. Maximum Peak Current Capability

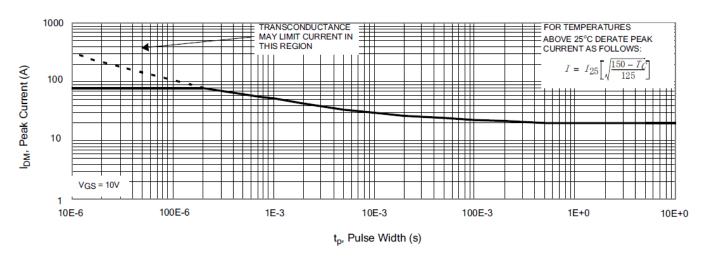


Figure 7. Typical Transfer Characteristics

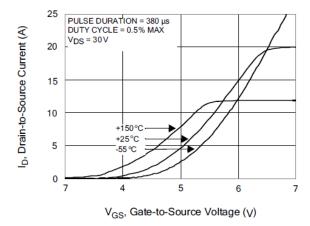
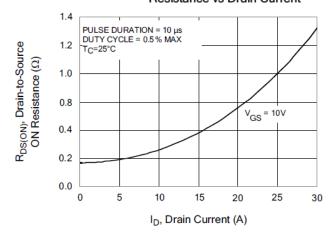


Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current



Unclamped Inductive Figure 8. Switching Capability

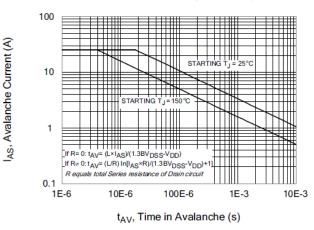
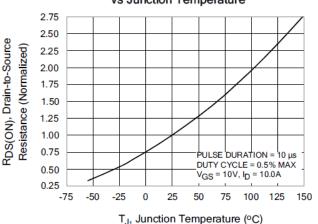


Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature



Junction Temperature

1.15

(page 40 Normalized Normali

-25

-50

0 25

0.90

-75

Figure 11. Typical Breakdown Voltage vs

T<sub>J</sub>, Junction Temperature (°C)

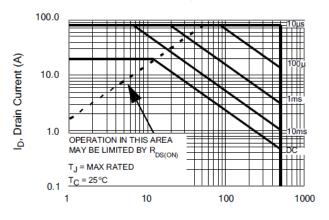
50

75

100

125

Figure 13. Maximum Forward Bias Safe Operating Area



 $V_{DS}$ , Drain-to-Source Voltage (V)

Figure 15. Typical Gate Charge vs Gate-to-Source Voltage

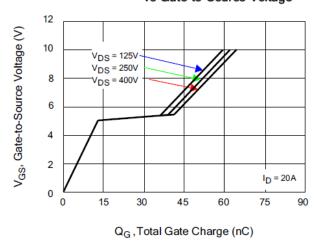


Figure 12. Typical Threshold Voltage vs Junction Temperature

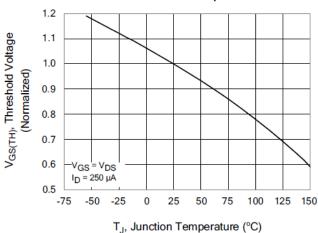


Figure 14. Typical Capacitance vs Drain-to-Source Voltage

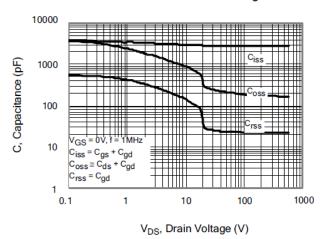
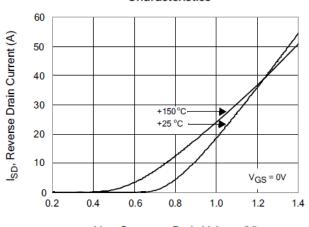


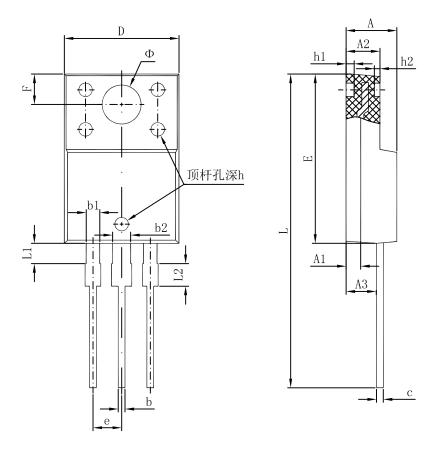
Figure 16. Typical Body Diode Transfer Characteristics



V<sub>SD</sub>, Source-to-Drain Voltage (V)



# Package Dimension TO-220F



Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min.	Max.	Min.	Max.	
Α	4.300	4.700	0.169	0.185	
A1	1.300	REF.	0.051 REF.		
A2	2.800	3.200	0.110	0.126	
A3	2.500	2.900	0.098	0.114	
b	0.500	0.750	0.020	0.030	
b1	1.100	1.350	0.043	0.053	
b2	1.500	1.750	0.059	0.069	
С	0.500	0.750	0.020	0.030	
D	9.960	10.360	0.392	0.408	
Е	14.800	15.200	0.583	0.598	
е	2.540 TYP.		0.100 TYP.		
F	2.700 REF.		0.106 REF.		
Φ	3.500 REF.		0.138 REF.		
h	0.000	0.300	0.000	0.012	
h1	0.800 REF.		0.031 REF.		
h2	0.500 REF.		0.020 REF.		
L	28.000	28.400	1.102	1.118	
L1	1.700	1.900	0.067	0.075	
L2	1.900	2.100	0.075	0.083	



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